Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/041,141	AGGARWAL ET AL.	
Examiner	Art Unit	
Thu V. Huynh	2178	

	SEARCHED			
Class	Subclass	Date	Examiner	
Update	Search	1/17/2008	тн	
715	505-508	1/17/2008	тн	
715	221-223	1/17/2008	TH -	
·				

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
		i	

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB, USPAT, JPO, EPO, DERWENT, IBM_TDB) See Search History Printout	1/17/2008	тн
·		
· · · · · · · · · · · · · · · · · · ·		